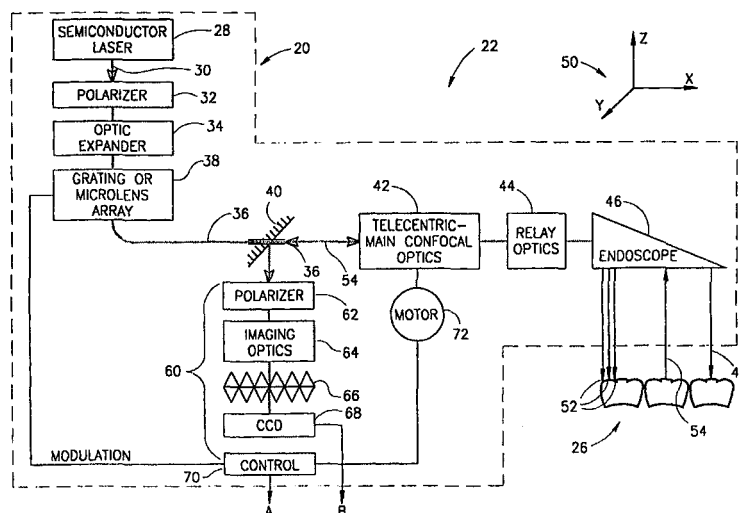




INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(51) International Patent Classification ⁷ : G01B 11/24, A61C 13/00, 19/04		A1	(11) International Publication Number: WO 00/08415
			(43) International Publication Date: 17 February 2000 (17.02.00)
(21) International Application Number: PCT/IL99/00431 (22) International Filing Date: 5 August 1999 (05.08.99) (30) Priority Data: 125659 5 August 1998 (05.08.98) IL (71) Applicant (for all designated States except US): CADENT LTD. [IL/IL]; Hamelacha Street 14, 60372 Or Yehuda (IL). (72) Inventors; and (75) Inventors/Applicants (for US only): BABAYOFF, Noam [IL/IL]; Laskov Street 25, 58672 Holon (IL). GLASER-INBARI, Isaia [IL/IL]; Hashnayim Street 24, 53230 Givataim (IL). (74) Agent: REINHOLD COHN AND PARTNERS; P.O. Box 4060, 61040 Tel-Aviv (IL).		(81) Designated States: AE, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BY, CA, CH, CN, CR, CU, CZ, DE, DK, EE, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MD, MG, MK, MN, MW, MX, NO, NZ, PL, PT, RO, RU, SD, SE, SG, SI, SK, SL, TJ, TM, TR, TT, UA, UG, US, UZ, VN, YU, ZA, ZW, ARIPO patent (GH, GM, KE, LS, MW, SD, SL, SZ, UG, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, CH, CY, DE, DK, ES, FI, FR, GB, GR, IE, IT, LU, MC, NL, PT, SE), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GW, ML, MR, NE, SN, TD, TG). Published <i>With international search report.</i> <i>Before the expiration of the time limit for amending the claims and to be republished in the event of the receipt of amendments.</i>	

(54) Title: IMAGING A THREE-DIMENSIONAL STRUCTURE BY CONFOCAL FOCUSING AN ARRAY OF LIGHT BEAMS



(57) Abstract

Determining surface topology of a portion (26) of a three-dimensional structure is provided. An array of incident light beams (36) passing through a focusing optics (42) and a probing face is shone on said portion. The focusing optics defines one or more focal planes forward the probing face in a position which can be changed (72) by the focusing optics. The beams generate illuminated spots (52) on the structure and the intensity of returning light rays propagating in an optical path opposite to that of the incident light rays is measured (60) at various positions of the focal plane(s). By determining spot-specific positions yielding a maximum intensity of the returned light beams, data is generated which is representative of said topology. Measurement of teeth. Light beams by grating of matrix of pinholes, micro lens array. Simultaneous imaging from three angles. Quicker with three different light components.

FOR THE PURPOSES OF INFORMATION ONLY

Codes used to identify States party to the PCT on the front pages of pamphlets publishing international applications under the PCT.

AL	Albania	ES	Spain	LS	Lesotho	SI	Slovenia
AM	Armenia	FI	Finland	LT	Lithuania	SK	Slovakia
AT	Austria	FR	France	LU	Luxembourg	SN	Senegal
AU	Australia	GA	Gabon	LV	Latvia	SZ	Swaziland
AZ	Azerbaijan	GB	United Kingdom	MC	Monaco	TD	Chad
BA	Bosnia and Herzegovina	GE	Georgia	MD	Republic of Moldova	TG	Togo
BB	Barbados	GH	Ghana	MG	Madagascar	TJ	Tajikistan
BE	Belgium	GN	Guinea	MK	The former Yugoslav	TM	Turkmenistan
BF	Burkina Faso	GR	Greece		Republic of Macedonia	TR	Turkey
BG	Bulgaria	HU	Hungary	ML	Mali	TT	Trinidad and Tobago
BJ	Benin	IE	Ireland	MN	Mongolia	UA	Ukraine
BR	Brazil	IL	Israel	MR	Mauritania	UG	Uganda
BY	Belarus	IS	Iceland	MW	Malawi	US	United States of America
CA	Canada	IT	Italy	MX	Mexico	UZ	Uzbekistan
CF	Central African Republic	JP	Japan	NE	Niger	VN	Viet Nam
CG	Congo	KE	Kenya	NL	Netherlands	YU	Yugoslavia
CH	Switzerland	KG	Kyrgyzstan	NO	Norway	ZW	Zimbabwe
CI	Côte d'Ivoire	KP	Democratic People's	NZ	New Zealand		
CM	Cameroon		Republic of Korea	PL	Poland		
CN	China	KR	Republic of Korea	PT	Portugal		
CU	Cuba	KZ	Kazakstan	RO	Romania		
CZ	Czech Republic	LC	Saint Lucia	RU	Russian Federation		
DE	Germany	LI	Liechtenstein	SD	Sudan		
DK	Denmark	LK	Sri Lanka	SE	Sweden		
EE	Estonia	LR	Liberia	SG	Singapore		

IMAGING A THREE-DIMENSIONAL STRUCTURE BY CONFOCAL FOCUSING AN ARRAY OF LIGHT BEAMS

FIELD OF THE INVENTION

This invention in the field of imaging techniques and relates to a method and an apparatus for non-contact imaging of three-dimensional structures, particularly useful for direct surveying of teeth.

5 BACKGROUND OF THE INVENTION

A great variety of methods and systems have been developed for direct optical measurement of teeth and the subsequent automatic manufacture of dentures. The term "*direct optical measurement*" signifies surveying of teeth in the oral cavity of a patient. This facilitates the obtainment of digital
10 constructional data necessary for the computer-assisted design (CAD) or computer-assisted manufacture (CAM) of tooth replacements without having to make any cast impressions of the teeth. Such systems typically includes an optical probe coupled to an optical pick-up or receiver such as charge coupled device (CCD) and a processor implementing a suitable image processing
15 technique to design and fabricate virtually the desired product.

One conventional technique of the kind specified is based on a laser-triangulation method for measurement of the distance between the surface of the tooth and the optical distance probe, which is inserted into the

oral cavity of the patient. The main drawback of this technique consists of the following. It is assumed that the surface of the tooth reflects optimally, e.g. Lambert's reflection. Unfortunately, this is not the case in practice and often the data that is obtained is not accurate.

5 Other techniques, which are embodied in CEREC-1 and CEREC-2 systems commercially available from Siemens GmbH or Sirona Dental Systems, utilize the light-section method and phase-shift method, respectively. Both systems employ a specially designed hand-held probe to measure the three-dimensional coordinates of a prepared tooth. However, the methods
10 require a specific coating (i.e. measurement powder and white-pigments suspension, respectively) to be deposited to the tooth. The thickness of the coating layer should meet specific, difficult to control requirements, which leads to inaccuracies in the measurement data.

By yet another technique, mapping of teeth surface is based on
15 physical scanning of the surface by a probe and by determining the probe's position, e.g. by optical or other remote sensing means, the surface may be imaged.

U.S. Patent No. 5,372,502 discloses an optical probe for three-dimensional surveying. The operation of the probe is based on the
20 following. Various patterns are projected onto the tooth or teeth to be measured and corresponding plurality of distorted patterns are captured by the probe. Each interaction provides refinement of the topography.

SUMMARY OF THE INVENTION

The present invention is directed to a method and apparatus for
25 imaging three-dimensional structures. A preferred, non-limiting embodiment, is concerned with the imaging of a three-dimensional topology of a teeth segment, particularly such where one or more teeth are missing. This may allow the generation of data for subsequent use in design and manufacture of,

for example, prosthesis of one or more teeth for incorporation into said teeth segment. Particular examples are the manufacture of crowns or bridges.

The present invention provides, by a first of its aspects, a method for determining surface topology of a portion of a three-dimensional structure,
5 comprising:

- 10 (a) providing an array of incident light beams propagating in an optical path leading through a focusing optics and a probing face; the focusing optics defining one or more focal planes forward said probing face in a position changeable by said optics, each light beam having its focus on one of said one or more focal plane; the beams generating a plurality of illuminated spots on the structure;
- (b) detecting intensity of returned light beams propagating from each of these spots along an optical path opposite to that of the incident light;
- 15 (c) repeating steps (a) and (b) a plurality of times, each time changing position of the focal plane relative to the structure; and
- (d) for each of the illuminated spots, determining a spot-specific position, being the position of the respective focal plane, yielding a maximum measured intensity of a respective returned light beam;
- 20 and
- (e) based on the determined spot-specific positions, generating data representative of the topology of said portion.

By a further of its aspects, the present invention provides an apparatus for determining surface topology of a portion of a
25 three-dimensional structure, comprising:

- a probing member with a sensing face;
- an illumination unit for providing an array of incident light beams transmitted towards the structure along an optical path through said probing unit to generate illuminated spots on said portion;

- a light focusing optics defining one or more focal planes forward said probing face at a position changeable by said optics, each light beam having its focus on one of said one or more focal plane ;
- a translation mechanism coupled to said focusing optics for displacing said focal plane relative to the structure along an axis defined by the propagation of the incident light beams;
- a detector having an array of sensing elements for measuring intensity of each of a plurality of light beams returning from said spots propagating through an optical path opposite to that of the incident light beams;
- a processor coupled to said detector for determining for each light beam a spot-specific position, being the position of the respective focal plane of said one or more focal planes yielding maximum measured intensity of the returned light beam, and based on the determined spot-specific positions, generating data representative of the topology of said portion.

The probing member, the illumination unit and the focusing optics and the translation mechanism are preferably included together in one device, typically a hand-held device. The device preferably includes also the detector.

The determination of the spot-specific positions in fact amounts to determination of the in-focus distance. The determination of the spot-specific position may be by measuring the intensity *per se*, or typically is performed by measuring the displacement (S) derivative of the intensity (I) curve (dI/dS) and determining the relative position in which this derivative function indicates a maximum maximum intensity. The term "*spot-specific position (SSP)*" will be used to denote the relative in-focus position regardless of the manner in which it is determined. It should be understood that the SSP is always a relative position as the absolute position depends on the position of the sensing face. However the generation of the surface topology does not require knowledge of the absolute position, as all dimensions in the cubic field of view are absolute.

The SSP for each illuminated spot will be different for different spots. The position of each spot in an **X-Y** frame of reference is known and by knowing the relative positions of the focal plane needed in order to obtain maximum intensity (namely by determining the SSP) , the **Z** or depth
5 coordinate can be associated with each spot and thus by knowing the **X-Y-Z** coordinates of each spot the surface topology can be generated.

In accordance with one embodiment, in order to determine the **Z** coordinate (namely the SSP) of each illuminated spot the position of the focal plane is scanned over the entire range of depth or **Z** component possible for
10 the measured surface portion. In accordance with another embodiment the beams have components which each has a different focal plane. Thus, in accordance with this latter embodiment by independent determination of SSP for the different light components, e.g. 2 or 3 with respective corresponding 2 or 3 focal planes, the position of the focal planes may be changed by the
15 focusing optics to scan only part of the possible depth range, with all focal planes together covering the expected depth range. In accordance with yet another embodiment, the determination of the SSP involves a focal plane scan of only part of the potential depth range and for illuminated spots where a maximum illuminated intensity was not reached, the SSP is determined by
20 extrapolation from the measured values or other mathematical signal processing methods.

The method and apparatus of the invention are suitable for determining a surface topology of a wide variety of three-dimensional structures. A preferred implementation of method and apparatus of the invention are in
25 determining surface topology of a teeth section.

In accordance with one embodiment of the invention, the method and apparatus are used to construct an object to be fitted within said structure. In accordance with the above preferred embodiment, such an object is at least one tooth or a portion of a tooth missing in the teeth section. Specific

examples include a crown to be fitted on a tooth stump or a bridge to be fitted within teeth.

By one embodiment of the invention, the plurality of incident light beams are produced by splitting a parent beam. Alternatively, each incident
5 light beam or a group of incident light beams may be emitted by a different light emitter. In accordance with a preferred embodiment, light emitted from a light emitter passes through a diffraction or refraction optics to obtain the array of light beams.

In accordance with one embodiment, the parent light beam is light
10 emitted from a single light emitter. In accordance with another embodiment, the parent light beam is composed of different light components, generated by different light emitters, the different light components differing from one another by at least one detectable parameter. Such a detectable parameter may, for example be wavelength, phase, different duration or pulse pattern, etc.
15 Typically, each of said light components has its focus in a plane differently distanced from the structure than other light components. In such a case, when the focal plane of the optics is changed, simultaneously the different ranges of depth (or **Z** component) will be scanned. Thus, in such a case, for each illuminated spot there will be at least one light component which will yield a
20 maximum intensity, and the focal distance associated with this light component will then define the **Z** component of the specific spot.

In accordance with an embodiment of the invention the incident light beams are polarized. In accordance with this embodiment, typically the apparatus comprises a polarization filter for filtering out, from the returned
25 light beams, light components having the polarization of the incident light, whereby light which is detected is that which has an opposite polarization to that of the incident light.

The data representative of said topology may be used for virtual reconstruction of said surface topology, namely for reconstruction within the

computer environment. The reconstructed topology may be represented on a screen, may be printed, etc., as generally known *per se*. Furthermore, the data representative of said topology may also be used for visual or physical construction of an object to be fitted within said structure. In the case of the
5 preferred embodiment noted above, where said structure is a teeth section with at least one missing tooth or tooth portion, said object is a prosthesis of one or more tooth, e.g. a crown or a bridge.

By determining surface topologies of adjacent portions, at times from two or more different angular locations relative to the structure, and then
10 combining such surface topologies, e.g in a manner known *per se*, a complete three-dimensional representation of the entire structure may be obtained. Data representative of such a representation may, for example, be used for virtual or physical reconstruction of the structure, may be transmitted to another apparatus or system for such reconstruction, e.g. to a CAD/CAM apparatus.
15 Typically, but not exclusively, the apparatus of the invention comprises a communication port for connection to a communication network which may be a computer network, a telephone network, a wireless communication network, etc.

BRIEF DESCRIPTION OF THE DRAWINGS

20 In order to understand the invention and to see how it may be carried out in practice, a preferred embodiment will now be described, by way of non-limiting example only, with reference to the accompanying drawings, in which:

Figs. 1A and 1B are a schematic illustration by way of a block diagram
25 of an apparatus in accordance with an embodiment of the invention (Fig. 1B is a continuation of Fig. 1A);

Fig. 2A is a top view of a probing member in accordance with an embodiment of the invention;

Fig. 2B is a longitudinal cross-section through line II-II in Fig. 2A, depicting also some exemplary rays passing therethrough;

Fig. 3 is a schematic illustration of another embodiment of a probing member ; and

5 **Fig. 4** is a schematic illustration of an embodiment where the parent light beam, and thus each of the incident light beams, is composed of several light components, each originating from a different light emitter.

DETAILED DESCRIPTION OF A PREFERRED EMBODIMENT

10 Reference is first being made to Figs. 1A and 1B illustrating, by way of a block diagram an apparatus generally designated 20, consisting of an optical device 22 coupled to a processor 24. The embodiment illustrated in Fig. 1 is particularly useful for determining the three-dimensional structure of a teeth segment 26, particularly a teeth segment where at least one tooth or
15 portion of tooth is missing for the purpose of generating data of such a segment for subsequent use in design or manufacture of a prosthesis of the missing at least one tooth or portion, e.g. a crown or a bridge. It should however be noted, that the invention is not limited to this embodiment, and applies, *mutatis mutandis*, also to a variety of other applications of imaging of
20 three-dimensional structure of objects, e.g. for the recordal or archeological objects, for imaging of a three-dimensional structure of any of a variety of biological tissues, etc.

Optical device 22 comprises, in this specific embodiment, a semiconductor laser unit 28 emitting a laser light, as represented by arrow 30.
25 The light passes through a polarizer 32 which gives rise to a certain polarization of the light passing through polarizer 32. The light then enters into an optic expander 34 which improves the numerical aperture of the light beam 30. The light beam 30 then passes through a module 38, which may, for example, be a grating or a micro lens array which splits the parent beam 30

into a plurality of incident light beams 36, represented here, for ease of illustration, by a single line. The operation principles of module 38 are known *per se* and the art and these principles will thus not be elaborated herein.

The light unit 22 further comprises a partially transparent mirror 40
5 having a small central aperture. It allows transfer of light from the laser source through the downstream optics, but reflects light travelling in the opposite direction. It should be noted that in principle, rather than a partially transparent mirror other optical components with a similar function may also be used, e.g. a beam splitter. The aperture in the mirror 40 improves the
10 measurement accuracy of the apparatus. As a result of this mirror structure the light beams will yield a light annulus on the illuminated area of the imaged object as long as the area is not in focus; and the annulus will turn into a completely illuminated spot once in focus. This will ensure that a difference between the measured intensity when out-of- and in-focus will be larger.
15 Another advantage of a mirror of this kind, as opposed to a beam splitter, is that in the case of the mirror internal reflections which occur in a beam splitter are avoided, and hence the signal-to-noise ratio improves.

The unit further comprises a confocal optics 42, typically operating in a telecentric mode, a relay optics 44, and an endoscopic probing member
20 46. Elements 42, 44 and 46 are generally as known *per se*. It should however be noted that telecentric confocal optics avoids distance-introduced magnification changes and maintains the same magnification of the image over a wide range of distances in the **Z** direction (the **Z** direction being the direction of beam propagation). The relay optics
25 enables to maintain a certain numerical aperture of the beam's propagation.

The endoscopic probing member typically comprises a rigid, light-transmitting medium, which may be a hollow object defining within it a light transmission path or an object made of a light transmitting material, e.g. a glass body or tube. At its end, the endoscopic probe typically

comprises a mirror of the kind ensuring a total internal reflection and which thus directs the incident light beams towards the teeth segment 26. The endoscope 46 thus emits a plurality of incident light beams 48 impinging on to the surface of the teeth section.

5 Incident light beams 48 form an array of light beams arranged in an X-Y plane, in the Cartesian frame 50, propagating along the Z axis. As the surface on which the incident light beams hits is an uneven surface, the illuminated spots 52 are displaced from one another along the Z axis, at different (X_i, Y_i) locations. Thus, while a spot at one location may be in
10 focus of the optical element 42, spots at other locations may be out-of-focus. Therefore, the light intensity of the returned light beams (see below) of the focused spots will be at its peak, while the light intensity at other spots will be off peak. Thus, for each illuminated spot, a plurality of measurements of light intensity are made at different positions along the
15 Z-axis and for each of such (X_i, Y_i) location, typically the derivative of the intensity over distance (Z) will be made, the Z_i yielding maximum derivative, Z_0 , will be the in-focus distance. As pointed out above, where, as a result of use of the punctured mirror 40, the incident light forms a light disk on the surface when out of focus and a complete light spot only when
20 in focus, the distance derivative will be larger when approaching in-focus position thus increasing accuracy of the measurement.

The light scattered from each of the light spots includes a beam travelling initially in the Z axis along the opposite direction of the optical path traveled by the incident light beams. Each returned light beam 54
25 corresponds to one of the incident light beams 36. Given the unsymmetrical properties of mirror 40, the returned light beams are reflected in the direction of the detection optics generally designated 60. The detection optics comprises a polarizer 62 that has a plane of preferred polarization oriented normal to the plane polarization of polarizer 32. The returned

polarized light beam **54** pass through an imaging optic **64**, typically a lens or a plurality of lenses, and then through a matrix **66** comprising an array of pinholes. CCD camera has a matrix or sensing elements each representing a pixel of the image and each one corresponding to one pinhole in the array
5 **66**.

The CCD camera is connected to the image-capturing module **80** of processor unit **24**. Thus, each light intensity measured in each of the sensing elements of the CCD camera, is then grabbed and analyzed, in a manner to be described below, by processor **24**.

10 Unit **22** further comprises a control module **70** connected to a controlling operation of both semi-conducting laser **28** and a motor **72**. Motor **72** is linked to telecentric confocal optics **42** for changing the relative location of the focal plane of the optics **42** along the Z-axis. In a single sequence of operation, control unit **70** induces motor **72** to displace the
15 optical element **42** to change the focal plane location and then, after receipt of a feedback that the location has changed, control module **70** will induce laser **28** to generate a light pulse. At the same time it will synchronize image-capturing module **80** to grab data representative of the light intensity from each of the sensing elements. Then in subsequent sequences the focal
20 plane will change in the same manner and the data capturing will continue over a wide focal range of optics **44, 44**.

Image capturing module **80** is connected to a CPU **82** which then determines the relative intensity in each pixel over the entire range of focal planes of optics **42, 44**. As explained above, once a certain light spot is in
25 focus, the measured intensity will be maximal. Thus, by determining the Z_i corresponding to the maximal light intensity or by determining the maximum displacement derivative of the light intensity, for each pixel, , the relative position of each light spot along the **Z** axis can be determined. Thus, data representative of the three-dimensional pattern of a surface in the

teeth segment, can be obtained. This three-dimensional representation may be displayed on a display **84** and manipulated for viewing, e.g. viewing from different angles, zooming-in or out, by the user control module **86** (typically a computer keyboard). In addition, the data representative of the surface topology may be transmitted through an appropriate data port, e.g. a modem **88**, through any communication network, e.g. telephone line **90**, to a recipient (not shown) e.g. to an off-site CAD/CAM apparatus (not shown).

By capturing, in this manner, an image from two or more angular locations around the structure, e.g. in the case of a teeth segment from the buccal direction, from the lingal direction and optionally from above the teeth, an accurate three-dimensional representation of the teeth segment may be reconstructed. This may allow a virtual reconstruction of the three-dimensional structure in a computerized environment or a physical reconstruction in a CAD/CAM apparatus.

As already pointed out above, a particular and preferred application is imaging of a segment of teeth having at least one missing tooth or a portion of a tooth, and the image can then be used for the design and subsequent manufacture of a crown or any other prosthesis to be fitted into this segment.

Reference is now being made to Figs. 2A AND 2B illustrating a probing member **90** in accordance with one, currently preferred, embodiment of the invention. The probing member **90** is made of a light transmissive material, typically glass and is composed of an anterior segment **91** and a posterior segment **92**, tightly glued together in an optically transmissive manner at **93**. Slanted face **94** is covered by a totally reflective mirror layer **95**. Glass disk **96** defining a sensing surface **97** is disposed at the bottom in a manner leaving an air gap **98**. The disk is fixed in position by a holding structure which is not shown. Three light rays are

99 are represented schematically. As can be seen, they bounce at the walls of the probing member at an angle in which the walls are totally reflective and finally bounce on mirror 94 and reflected from there out through the sensing face 97. The light rays focus on focusing plane 100, the position of
5 which can be changed by the focusing optics (not shown in this figure).

Reference is now being made to Fig. 3, which is a schematic illustration of an endoscopic probe in accordance with an embodiment of the invention. The endoscopic probe, generally designated 101, has a stem 102 defining a light transmission path (e.g., containing a void
10 elongated space, being made of or having an interior made of a light transmitting material. Probe 102 has a trough-like probe end 104 with two lateral probe members 106 and 108 and a top probe member 110. The optical fibers have light emitting ends in members 106, 108 and 110 whereby the light is emitted in a direction normal to the planes defined by
15 these members towards the interior of the trough-like structure 104. The probe is placed over a teeth segment 120, which in the illustrated case consists of two teeth 122 and 124, and a stamp 126 of a tooth for placement of a crown thereon. Such a probe will allow the simultaneous imaging of the surface topology of the teeth segment from three angles and
20 subsequently the generation of a three-dimensional structure of this segment.

Reference is now being made to Fig. 4. In this figure, a number of components of an apparatus generally designated 150 in accordance with another embodiment are shown. Other components, not shown, may be
25 similar to those of the embodiment shown in Fig. 1. In this apparatus a parent light beam 152 is a combination of light emitted by a number of laser light emitters 154A, 154B and 154C. Optic expander unit 156 then expands the single parent beam into an array of incident light beams 158. Incident

light beams pass through unidirectional mirror 160, then through optic unit 162 towards object 164.

The different light components composing parent beam 152 may for example be different wavelengths, a different one transmitted from each of laser emitters 154A-C. Thus, parent light beam 152 and each of incident light beams 158 will be composed of three different light components. The image of the optics, or an optical arrangement associated with each of light emitters may be arranged such that each light component focuses on a different plane, P_A , P_B and P_C , respectively. Thus in the position shown in Fig. 3, incident light beam 158A bounces on the surface at spot 170A which in the specific optical arrangement of optics 162 is in the focal point for light component A (emitted by light emitter 154A). Thus, the returned light beam 172A, passing through detection optics 174 yield maximum measured intensity of light component A measured by two-dimensional array of spectrophotometers 176, e.g. a 3 CHIP CCD camera. Similarly, different maximal intensity will be reached for spots 170B and 170C for light components B and C, respectively.

Thus, by using different light components each one focused simultaneously at a different plane, the time measurement can be reduced as different focal plane ranges can simultaneously be measured.

CLAIMS:

1. A method for determining surface topology of a portion of a three-dimensional structure, comprising:
 - 5 (a) providing an array of incident light beams propagating in an optical path leading through a focusing optics and through a probing face; the focusing optics defining one or more focal planes forward said probing face in a position changeable by said optics, each light beam having its focus on one of said one or more focal plane; the beams generating a plurality of illuminated spots on the
10 structure;
 - (b) detecting intensity of returned light beams propagating from each of these spots along an optical path opposite to that of the incident light;
 - (c) repeating steps (a) and (b) a plurality of times, each time changing
15 position of the focal plane relative to the structure;
 - (d) for each of the illuminated spots, determining a spot-specific position, being the position of the respective focal plane yielding a maximum measured intensity of a respective returned light beam; and
 - 20 (e) generating data representative of the topology of said portion.
2. The method according to Claim 1, wherein the plurality of incident light beams are produced by splitting a single parent beam.
3. The method according to Claim 1, wherein step (a) comprises polarizing the incident light beams.
- 25 4. The method according to Claim 3, wherein step (b) comprises filtering light having polarization same as the incident light and measuring light of opposite polarization.

5. The method according to any one of Claims 1-4, wherein each of said beams is composed of at least two light components different in at least one parameter.
6. The method according to Claim 5, wherein said at least one
5 parameter is selected from the group consisting of wavelength, phase, light pulse duration and pattern.
7. The method according to Claim 5, comprising, in step (b), determining intensity independently for each of said at least two light components in the return light beams.
- 10 8. The method according to Claim 7, wherein each of said at least two light components focuses in a plane differently distanced from the sensing surface.
9. The method according to any one of Claims 1-8, wherein the data representative of said topology is used for constructing an object to be fitted
15 within said structure.
10. The method according to any one of Claims 1-9, wherein the data representative of said topology is converted into a form transmissible through a communication medium to recipient.
11. The method according to any one of the preceding claims, wherein
20 said structure is a teeth segment.
12. The method according to Claim 12, wherein said structure is a teeth segment with at least one missing tooth or a portion of a tooth and said object is said at least one missing tooth or the portion of the tooth.
13. A method for reconstruction of topology of a three-dimensional
25 structure comprising:
 - (i) determining surface topologies from at least two different positions or angular locations relative to the structure, by the method defined in any one of Claims 1-12;

(ii) combining the surface topologies to obtain data representative of said structure.

14. The method according to Claim 13, for reconstruction of topology of a teeth portion, comprising:

- 5 - determining surface topologies of at least a buccal surface and a lingual surface of the teeth portion;
- combining the surface topologies to obtain data representative of a three-dimensional structure of said teeth portion.

15. The method according to Claim 14, for obtaining data representative
10 of a three-dimensional structure of a teeth portion with at least one missing tooth or a portion of a tooth.

16. The method according to Claim 15, wherein said data is used in a process of designing or manufacturing of a prostheses of said at least one missing tooth or a portion of a tooth.

15 17. The method according to Claim 16, wherein said prostheses is a crown or a bridge.

18. An apparatus for determining surface topology of a portion of a three-dimensional structure, comprising:

- a probing member with a sensing face;
- 20 - an illumination unit for providing an array of incident light beams transmitted towards the structure along an optical path through said probing unit to generate illuminated spots on said portion ;
- a light focusing optics defining one or more focal planes forward said probing face at a position changeable by said optics, each light beam
25 having its focus on one of said one or more focal plane;
- a translation mechanism for displacing said focal plane relative to the structure along an axis defined by the propagation of the incident light beams;

- a detector having an array of sensing elements for measuring intensity of each of a plurality of light beams returning from said spots propagating through an optical path opposite to that of the incident light beams;
- a processor coupled to said detector for determining for each light beam a spot-specific position, being the position of the respective focal plane of said one or more focal planes yielding maximum measured intensity of the returned light beam, and based on the determined spot-specific positions, generating data representative of the topology of portion.

19. The apparatus according to Claim 18, wherein said illumination unit comprises a source emitting a parent light beam and a beam splitter for splitting the parent beam into said array of incident light beams.

20. The apparatus according to Claim 19, wherein said illumination unit comprises a grating or microlens array.

21. The apparatus according to any one of Claims 18-20, comprising a polarizer for polarizing said incident light beams are polarized.

22. The apparatus according to Claim 21, comprising a polarization filter for filtering out from the returned light beams light components having the polarization of the incident light beams.

23. The apparatus according to any one of Claim 18-22, wherein the illumination unit comprises at least two light sources and each of said incident beams is composed of light components from the at least two light sources.

24. The apparatus according to Claim 23, wherein the at least two light sources emit each a light component of different wavelength.

25. The apparatus according to Claim 24, wherein said light directing optics defines a different focal plane for each light component and the detector independently detects intensity of each light components.

26. The apparatus according to Claim 23, wherein the at least two light sources are located so as to define optical paths of different lengths for the incident light beams emitted by each of the at least two light sources.

27. The apparatus according to any one of Claims 18-26, wherein said focusing optics operates in a telecentric confocal mode.
28. The apparatus according to any one of Claims 18-27, wherein said light directing optics comprises optical fibers.
- 5 29. The apparatus according to any one of Claims 18-28, wherein said sensing elements are an array of charge coupled devices (CCD).
30. The apparatus according to Claim 29, wherein, said detector unit comprises a pinhole array, each pinhole corresponding to one of the CCDs in the CCD array.
- 10 31. The apparatus according to any one of Claims 18-30, comprising a unit for generating data for transmission to CAD/CAM device.
32. The apparatus according to Claim 31, comprising a communication port of a communication medium.
33. The apparatus according to any one of Claims 18-32, for determining
15 surface topology of a teeth portion, comprising an optical probing member for placing proximal to the teeth.

1/5

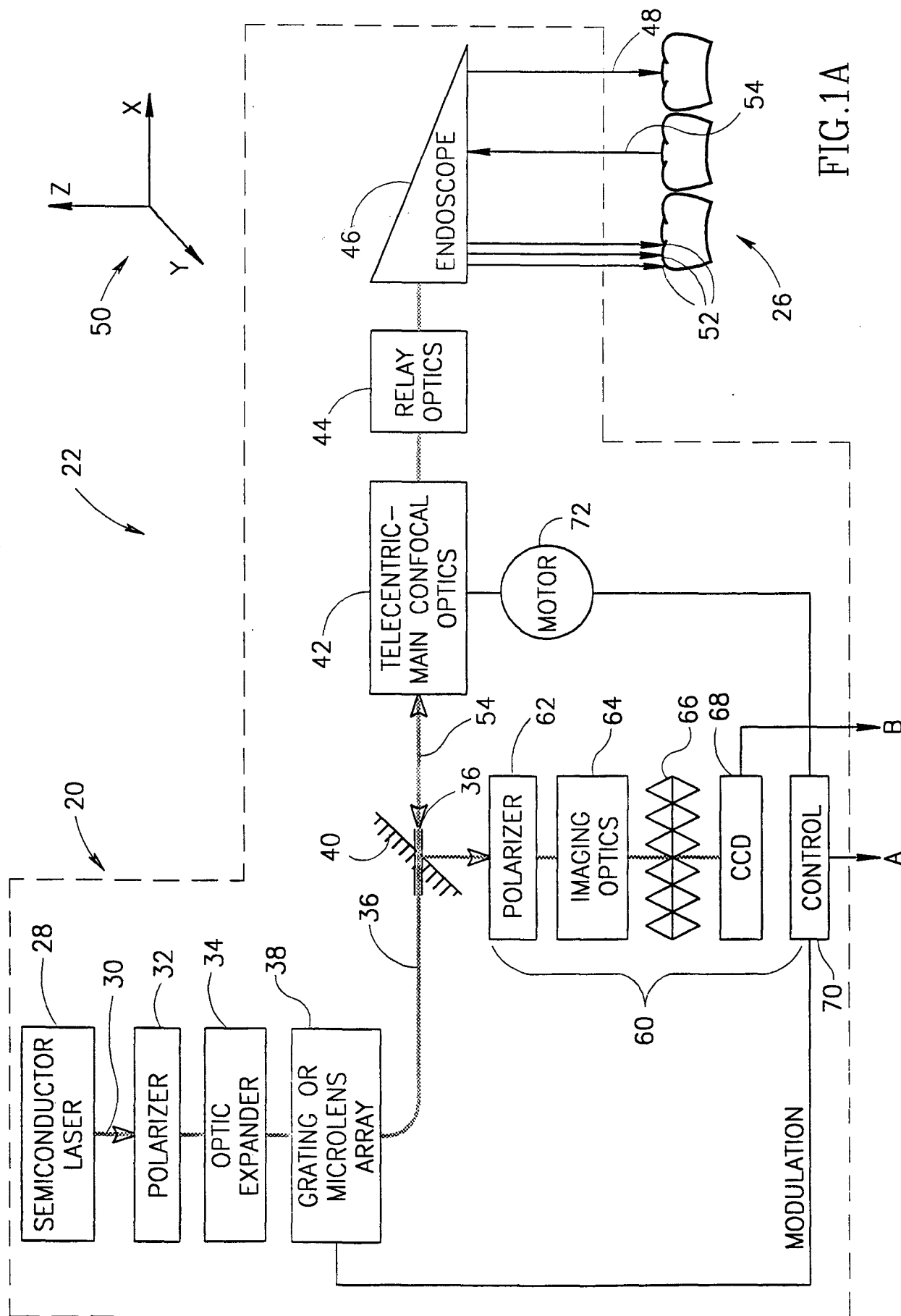


FIG. 1A

2/5

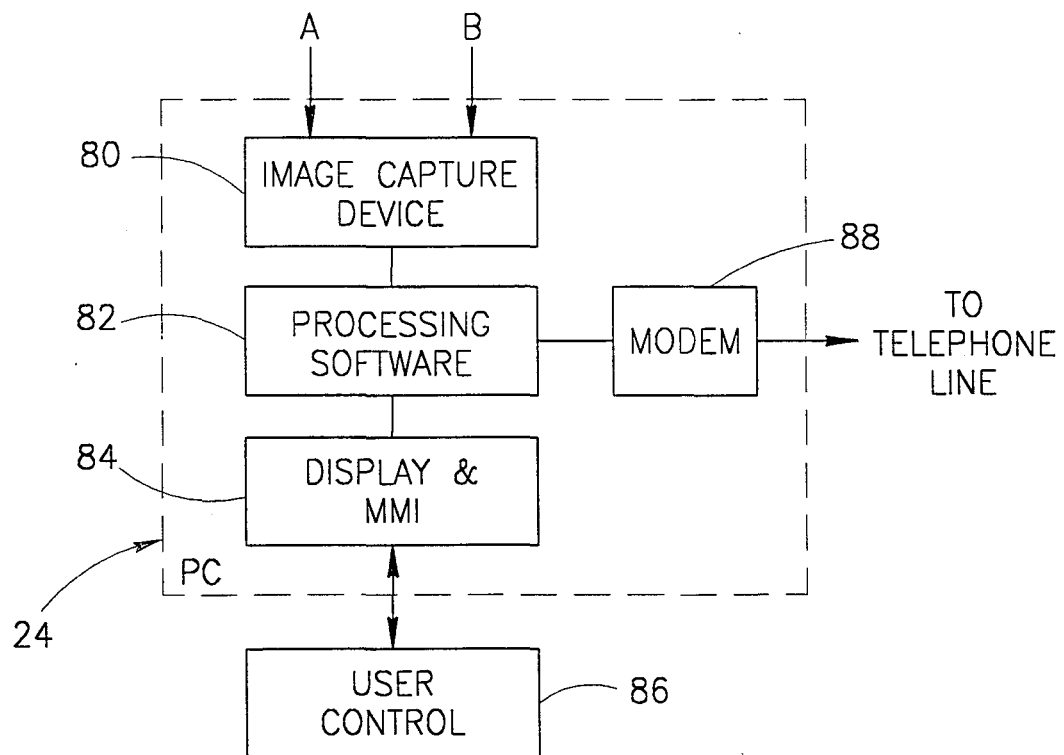
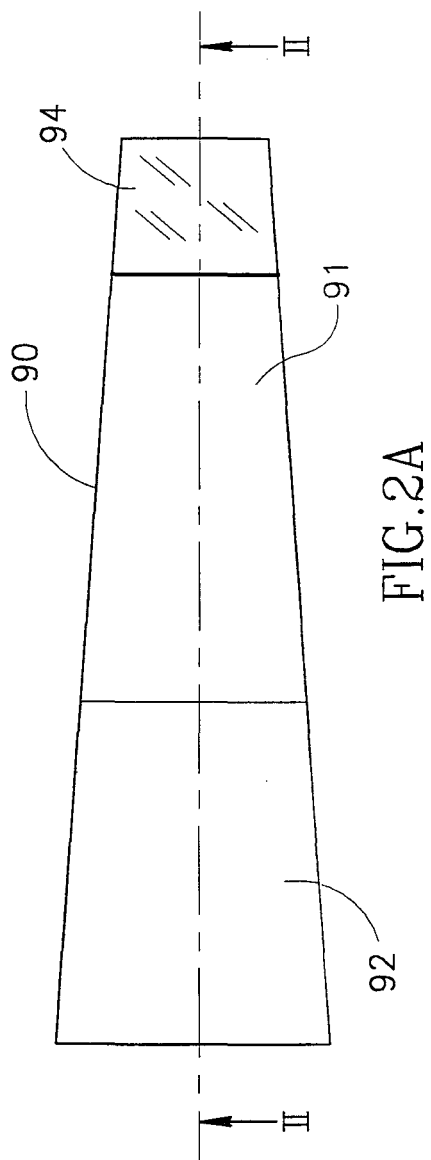
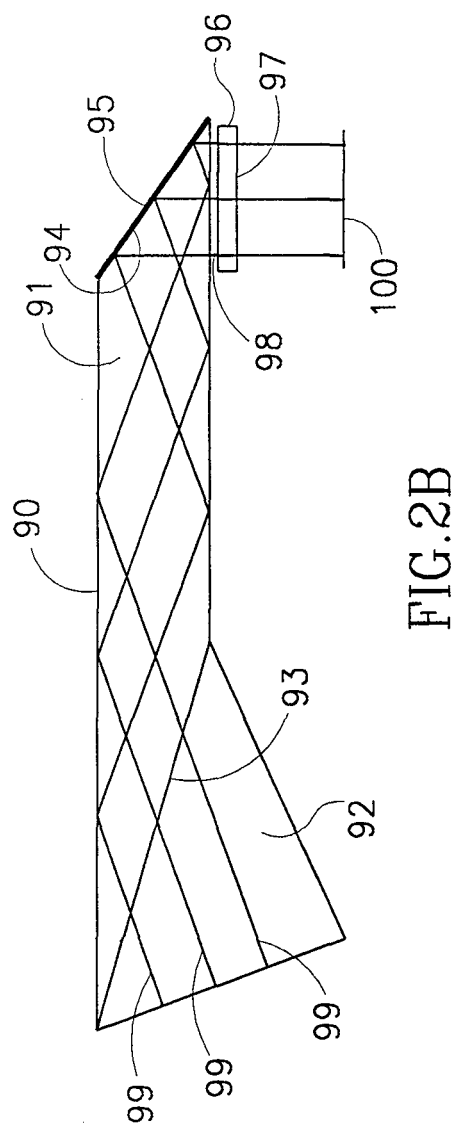


FIG.1B



4/5

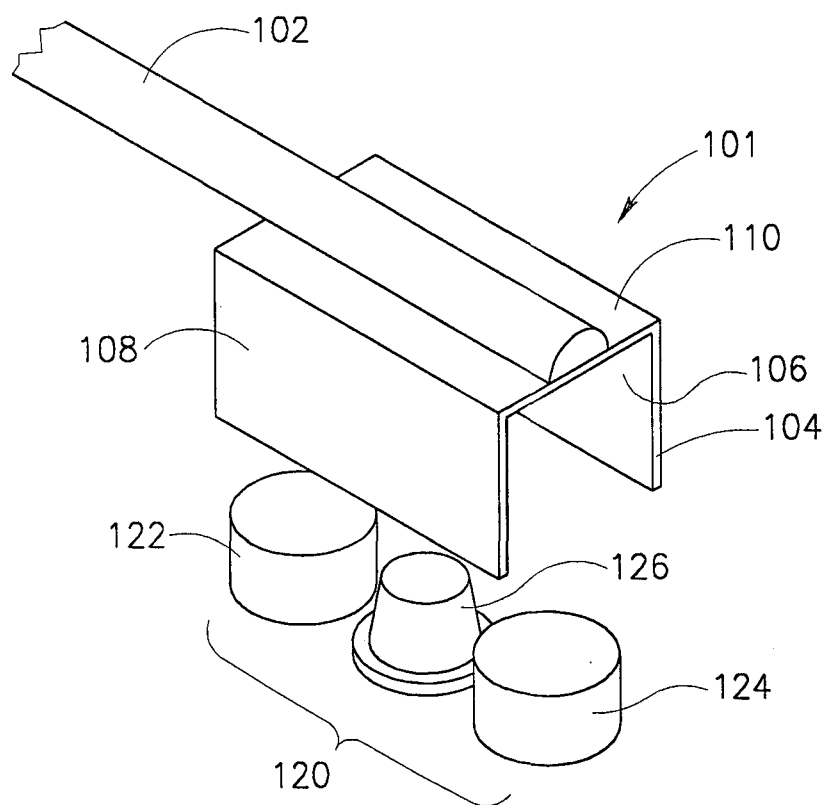


FIG.3

5/5

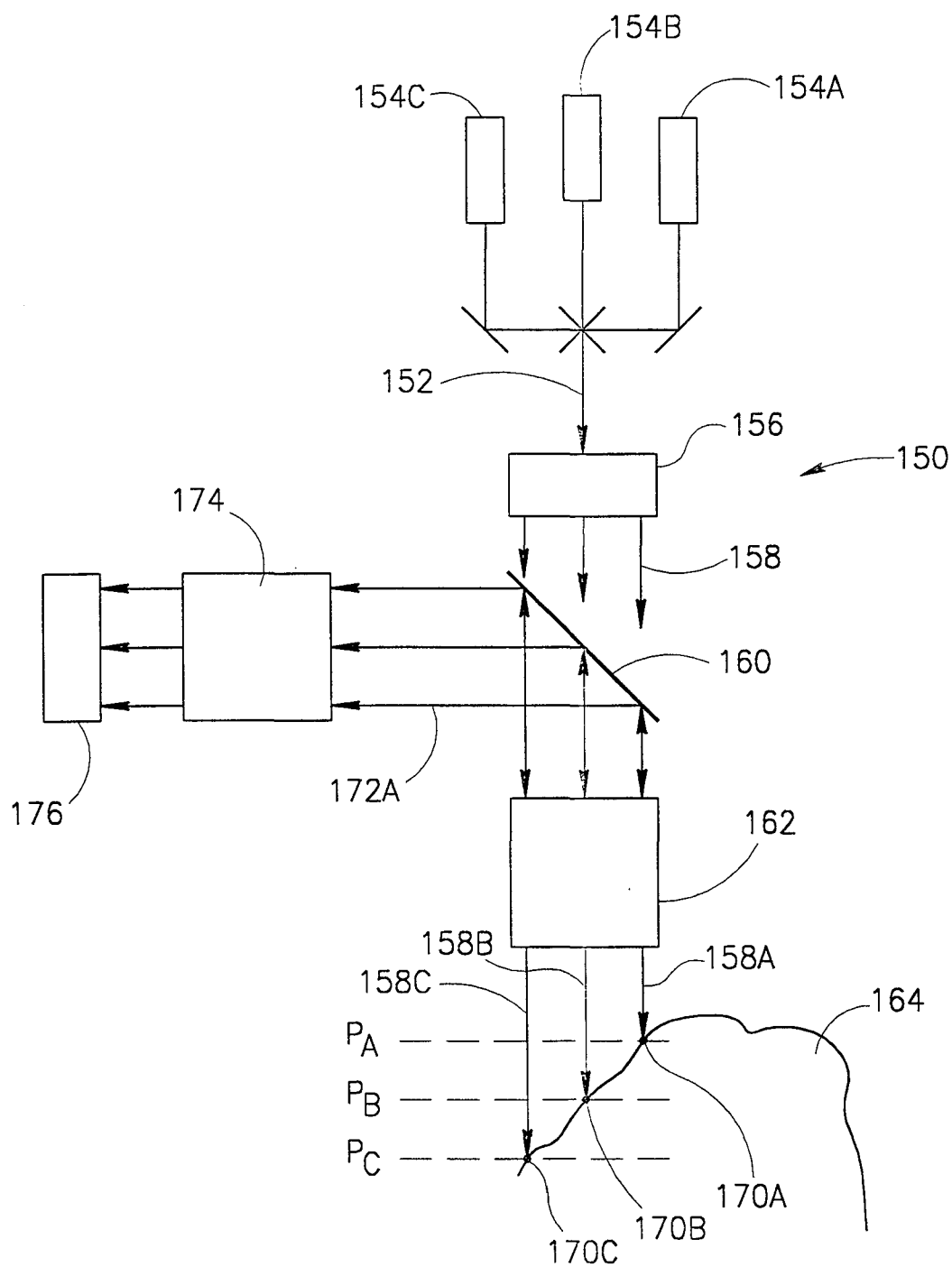


FIG.4

INTERNATIONAL SEARCH REPORT

International Application No

PCT/IL 99/00431

A. CLASSIFICATION OF SUBJECT MATTER

IPC 7 G01B11/24 A61C13/00 A61C19/04

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC 7 G01B A61C

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category °	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	EP 0 679 864 A (KOMATSU) 2 November 1995 (1995-11-02) column 2, line 9 - line 27; figure 25 ---	1, 18
X	GB 2 321 517 A (YOKOGAWA) 29 July 1998 (1998-07-29) figures 3,6,7 ---	1-3, 18-21
A	DE 196 38 758 A (RUBBERT) 19 March 1998 (1998-03-19) figure 4 ---	1, 18
A	US 4 575 805 A (MOERMANN ET AL.) 11 March 1986 (1986-03-11) column 9, line 61 -column 10, line 42 --- -/--	13



Further documents are listed in the continuation of box C.



Patent family members are listed in annex.

° Special categories of cited documents :

"A" document defining the general state of the art which is not considered to be of particular relevance

"E" earlier document but published on or after the international filing date

"L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)

"O" document referring to an oral disclosure, use, exhibition or other means

"P" document published prior to the international filing date but later than the priority date claimed

"T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention

"X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone

"Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art.

"&" document member of the same patent family

Date of the actual completion of the international search

30 November 1999

Date of mailing of the international search report

06/12/1999

Name and mailing address of the ISA

European Patent Office, P.B. 5818 Patentlaan 2
NL - 2280 HV Rijswijk
Tel. (+31-70) 340-2040, Tx. 31 651 epo nl,
Fax: (+31-70) 340-3016

Authorized officer

Mielke, W

INTERNATIONAL SEARCH REPORT

International Application No

PCT/IL 99/00431

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	GB 2 144 537 A (ISTITUTO) 6 March 1985 (1985-03-06) page 2, line 26 - line 49; figure 2 ---	5,23
A	US 5 737 084 A (TAKAOKA) 7 April 1998 (1998-04-07) figures 5-7 ---	20
A	DE 196 50 391 A (LEICA) 10 June 1998 (1998-06-10) figure 1 ---	
A	DE 196 40 495 A (LEICA) 9 April 1998 (1998-04-09) figure 1 ---	
A	WO 97 37264 A (KOMATSU) 9 October 1997 (1997-10-09) figure 1 ---	
A	US 5 381 236 A (OXFORD SENSOR) 10 January 1995 (1995-01-10) column 3, line 21 - line 44; figure 1 -----	

INTERNATIONAL SEARCH REPORT

Information on patent family members

International Application No

PCT/IL 99/00431

Patent document cited in search report	Publication date	Patent family member(s)	Publication date
EP 0679864 A	02-11-1995	US 5659420 A WO 9509346 A JP 7181023 A	19-08-1997 06-04-1995 18-07-1995
GB 2321517 A	29-07-1998	NONE	
DE 19638758 A	19-03-1998	AU 4111497 A WO 9811403 A EP 0935736 A	02-04-1998 19-03-1998 18-08-1999
US 4575805 A	11-03-1986	AT 14073 T EP 0054785 A JP 1665145 C JP 3017494 B JP 57173053 A	15-07-1985 30-06-1982 19-05-1992 08-03-1991 25-10-1982
GB 2144537 A	06-03-1985	IT 1198660 B DE 3428593 A FR 2550332 A	21-12-1988 14-02-1985 08-02-1985
US 5737084 A	07-04-1998	JP 9096512 A JP 9126739 A JP 9257440 A US 5946100 A	08-04-1997 16-05-1997 03-10-1997 31-08-1999
DE 19650391 A	10-06-1998	WO 9825171 A EP 0943113 A	11-06-1998 22-09-1999
DE 19640495 A	09-04-1998	WO 9814132 A	09-04-1998
WO 9737264 A	09-10-1997	JP 9264720 A	07-10-1997
US 5381236 A	10-01-1995	AU 1195892 A DE 69207176 D DE 69207176 T EP 0571431 A WO 9214118 A JP 6505096 T JP 6506287 T	07-09-1992 08-02-1996 04-07-1996 01-12-1993 20-08-1992 09-06-1994 14-07-1994